



MH250 Hall-effect sensor is a temperature stable, stress-resistant, Low Tolerance of Sensitivity micro-power switch. Superior high-temperature performance is made possible through a dynamic offset cancellation that utilizes chopper-stabilization. This method reduces the offset voltage normally caused by device over molding, temperature dependencies, and thermal stress.

MH250 is special made for low operation voltage, 1.7V, to active the chip which is includes the following on a single silicon chip: voltage regulator, Hall voltage generator, small-signal amplifier, chopper stabilization, Schmitt trigger, open-drain output. Advanced CMOS wafer fabrication processing is used to take advantage of low-voltage requirements, component matching, very low input-offset errors, and small component geometries. This device requires the presence of omni-polar magnetic fields for operation.

MH250 is rated for operation between the ambient temperatures  $-40^{\circ}\text{C}$  and  $+85^{\circ}\text{C}$  for the E temperature range. The four package styles available provide magnetically optimized solutions for most applications. Package types SO is an SOT-23(1.1 mm nominal height), ST is an TSOT-23(0.8 mm nominal height), SQ is an QFN2020-3(0.55 mm nominal height), a miniature low-profile surface-mount package, while package UA is a three-lead ultra mini SIP for through-hole mounting.

The package type is in a Halogen Free version has been verified by third party Lab.


### ***Features and Benefits***

- CMOS Hall IC Technology
- MST patented RF noise protection
- 1.7 to 3.5V for battery-powered applications
- Omni polar, output switches with absolute value of North or South pole from magnet
- Operation down to 1.7V, Micro power consumption
- High Sensitivity for direct reed switch replacement applications
- Low sensitivity drift in crossing of Temp. range
- Ultra Low power consumption at 3uA (Avg)
- Green chip is qualified by third party lab.
- High ESD Protection, HBM >  $\pm 4\text{KV}$ ( min )

### ***Applications***

- Solid state switch
- Handheld Wireless Handset Awake Switch ( Flip Cell/PHS Phone/Note Book/Flip Video Set)
- Lid close sensor for battery powered devices
- Magnet proximity sensor for reed switch replacement in low duty cycle applications
- Floating Meter
- PDVD
- NB

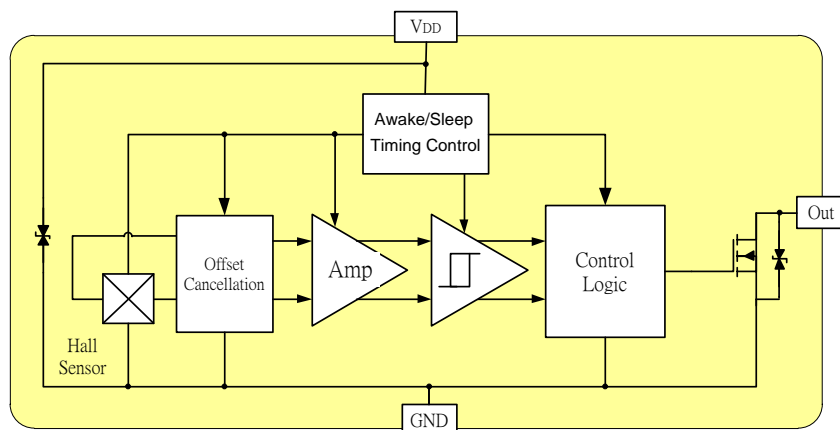
### Ordering Information

	<p><b>Company Name and Product Category</b></p> <p>MH:MST Hall Effect/MP:MST Power MOSFET</p> <p><b>Part number</b></p> <p>181,182,183,184,185,248,249,276,477,381,381F,381R,382.....</p> <p>If part # is just 3 digits, the fourth digit will be omitted.</p> <p><b>Temperature range</b></p> <p>E: 85 °C, I: 105 °C, K: 125 °C, L: 150 °C</p> <p><b>Package type</b></p> <p>UA:TO-92S,VK:TO-92S(4pin),VF:TO-92S(5pin),SO:SOT-23, SQ:QFN-3,ST:TSOT-23,SN:SOT-553,SF:SOT-89(5pin)</p> <p><b>Sorting</b></p> <p><math>\alpha, \beta</math>, Blank.....</p>
<p>Sorting Code</p> <p>Package type</p> <p>Temperature Code</p> <p>Part number</p> <p>Company Name and Product Category</p>	

Part No.	Temperature Suffix	Package Type
MH250EUA	E (-40°C to + 85°C)	UA (TO-92S)
MH250ESO	E (-40°C to + 85°C)	SO (SOT-23)
MH250EST	E (-40°C to + 85°C)	ST (TSOT-23)
MH250ESQ	E (-40°C to + 85°C)	SQ (QFN2020-3)

Custom sensitivity selection is available by MST sorting technology

### Functional Diagram



**Note:** Static sensitive device; please observe ESD precautions. Reverse  $V_{DD}$  protection is not included. For reverse voltage protection, a  $100\ \Omega$  resistor in series with  $V_{DD}$  is recommended.

**MH250, HBM >  $\pm 4KV$  which is verified by third party lab.**

**Absolute Maximum Ratings At ( $T_a=25^\circ\text{C}$ )**

Characteristics		Values	Unit
Supply voltage, ( $V_{DD}$ )		7	V
Output Voltage, ( $V_{out}$ )		6	V
Reverse voltage, ( $V_{DD}$ ) ( $V_{out}$ )		-0.3	V
Magnetic flux density		Unlimited	Gauss
Output current ( $I_{out}$ )		5	mA
Operating temperature range, ( $T_a$ )		-40 to +85	$^\circ\text{C}$
Storage temperature range, ( $T_s$ )		-65 to +150	$^\circ\text{C}$
Maximum Junction Temp, ( $T_j$ )		150	$^\circ\text{C}$
Thermal Resistance	( $\theta_{JA}$ ) UA / SO / ST / SQ	206 / 543 / 310 / 543	$^\circ\text{C}/\text{W}$
	( $\theta_{JC}$ ) UA / SO / ST / SQ	148 / 410 / 223 / 410	$^\circ\text{C}/\text{W}$
Package Power Dissipation, ( $P_D$ ) UA / SO / ST / SQ		606 / 230 / 400 / 230	mW

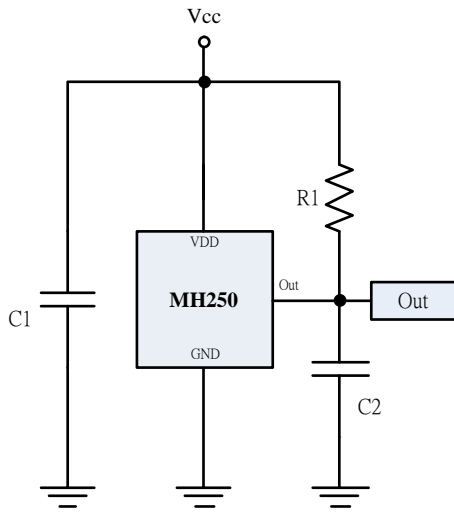
*Note: Exceeding the absolute maximum ratings may cause permanent damage. Exposure to absolute maximum-rated conditions for extended periods may affect device reliability.*

**Electrical Specifications**

*DC Operating Parameters :  $T_a=25^\circ\text{C}$ ,  $V_{DD}=1.8\text{V}$*

Parameters	Test Conditions	Min	Typ	Max	Units
Supply Voltage, ( $V_{DD}$ )	Operating	1.7		3.5	V
Supply Current, ( $I_{DD}$ )	Awake State		0.9		mA
	Sleep State		1.6		$\mu\text{A}$
	Average		2.3		$\mu\text{A}$
Output Leakage Current, ( $I_{off}$ )	Output off			1	$\mu\text{A}$
Output Low Voltage, ( $V_{sat}$ )	$I_{OUT}=1\text{mA}$			0.2	V
Awake mode time, ( $T_{aw}$ )	Operating		70		$\mu\text{S}$
Sleep mode time, ( $T_{SL}$ )	Operating		100		mS
Duty Cycle, ( $D, C$ )			0.07		%
Electro-Static Discharge	HBM	4			KV
Operate Point, ( $B_{OPS}$ )	S pole to branded side, $B > BOP$ , $V_{out}$ On		30	40	Gauss
	N pole to branded side, $B > BOP$ , $V_{out}$ On	-40	-30		
Release Point ( $B_{RPS}$ )	S pole to branded side, $B < BRP$ , $V_{out}$ Off	20	25		Gauss
	N pole to branded side, $B < BRP$ , $V_{out}$ Off		-25	-20	
Hysteresis, ( $B_{HYS}$ )	$ BOPx - BRPx $		5		Gauss

**Typical Application circuit**

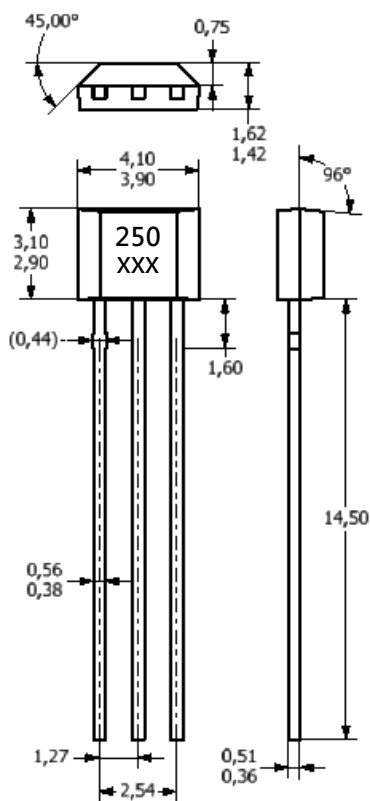


C1 : 10nF  
 C2 : 100pF  
 R1 : 100KΩ

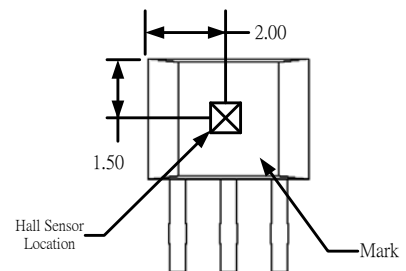
**Sensor Location, Package Dimension and Marking**

**MH250 Package**

**UA Package**



**Hall Chip location**



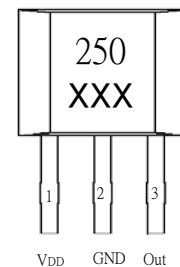
**NOTES:**

- 1).Controlling dimension: mm
- 2).Leads must be free of flash and plating voids
- 3).Do not bend leads within 1 mm of lead to package interface.

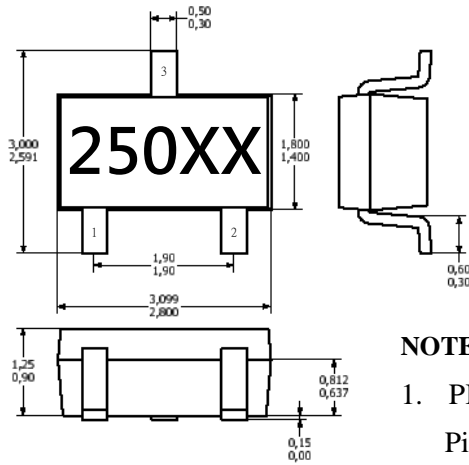
**4).PINOUT:**

Pin 1	VDD
Pin 2	GND
Pin 3	Output

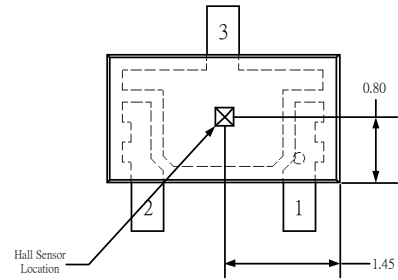
**Output Pin Assignment (Top view)**



**SO Package**  
**(Top View)**



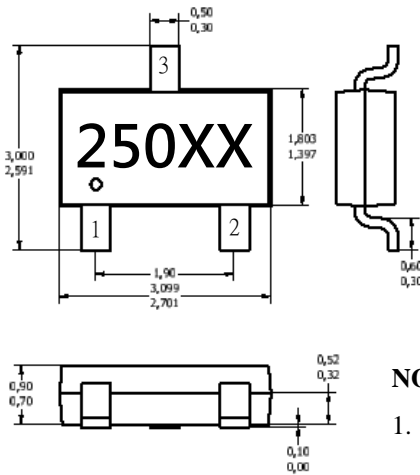
**Hall Plate Chip Location**  
**(Bottom view)**



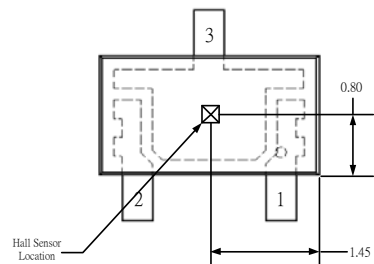
**NOTES:**

1. PINOUT (See Top View at left :)  
 Pin 1 V<sub>DD</sub>  
 Pin 2 Output  
 Pin 3 GND
2. Controlling dimension: mm
3. Lead thickness after solder plating will be 0.254mm maximum

**ST Package (TSOT-23)**  
**(Top View)**



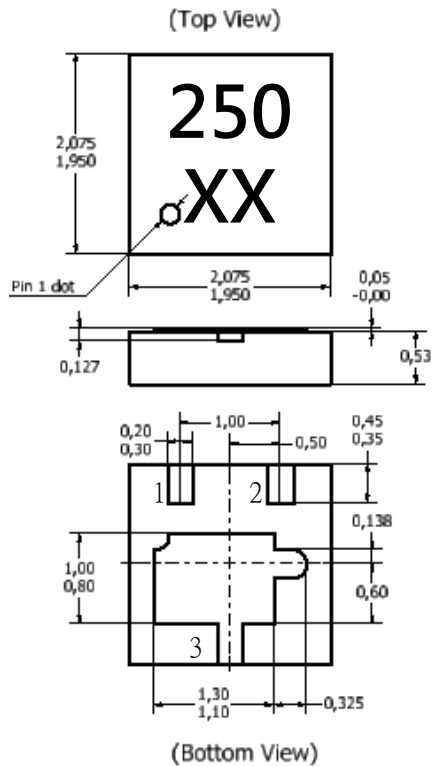
**Hall Plate Chip Location**  
**(Bottom view)**



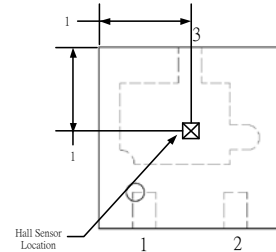
**NOTES:**

1. PINOUT (See Top View at left:)  
 Pin 1 V<sub>DD</sub>  
 Pin 2 Output  
 Pin 3 GND
2. Controlling dimension: mm;

**SQ Package**



**Hall Plate Chip Location**  
**(Top view)**



**NOTES:**

3. PINOUT (See Top View at left)
  - Pin 1 VDD
  - Pin 2 Output
  - Pin 3 GND
4. Controlling dimension: mm;
5. Chip rubbing will be 10mil maximum;
6. Chip must be in PKG. center.